

SEARCH NOTES				Application No.	Applicant(s)
				10/042,831	LEE ET AL.
				Examiner	Art Unit
				Sean Reilly	2153
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)	
Class	Subclass	Date	Examiner		DATE
708	204, 205, 206, 207	4/14/2005	SR	See attached EAST search.	4/14/2005
				Consulted w/ Primary Examiner Dinh	4/15/2005
				Searched ACM and IEEE NPL databases.	4/15/2005
				Consulted w/ Andy Caldwell	10/11/05
				Updated class search.	6/17/06
				Updated class search	2/28/07
				Consulted w/ SPE Burgess regarding a rejection in	2/16/07
				view of Patent 7,016, 935	
INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		